## MC74HCT259A

## 8-Bit Addressable Latch 1-of-8 Decoder with LSTTL Inputs

## High-Performance Silicon-Gate CMOS

The MC74HCT259A is identical in pinout to the LS259. The device inputs are compatible with standard CMOS and LSTTL outputs.

The HCT259A has four modes of operation as shown in the mode selection table. In the addressable latch mode, the data on Data In is written into the addressed latch. The addressed latch follows the data input with all non-addressed latches remaining in their previous states. In the memory mode, all latches remain in their previous state and are unaffected by the Data or Address inputs. In the one-of-eight decoding or demultiplexing mode, the addressed output follows the state of Data In with all other outputs in the LOW state. In the Reset mode all outputs are LOW and unaffected by the address and data inputs. When operating the HCT259A as an addressable latch, changing more than one bit of the address could impose a transient wrong address. Therefore, this should only be done while in the memory mode.

## Features

- Output Drive Capability: 10 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS, and THL
- Operating Voltage Range: 4.5 to 5.5 V
- Low Input Current: $1 \mu \mathrm{~A}$
- High Noise Immunity Characteristic of CMOS Devices
- These are Pb -Free Devices


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PIN ASSIGNMENT


MODE SELECTION TABLE

| Enable | Reset | Mode |
| :---: | :---: | :---: |
| L | H | Addressable Latch |
| H | H | Memory |
| L | L | 8-Line Demultiplexer |
| H | L | Reset |

## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.


Figure 1. Logic Diagram

## MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit | This device contains protection |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC Supply Voltage (Referenced to GND) | -0.5 to +7.0 | V | try to guard against damage |
| $V_{\text {in }}$ | DC Input Voltage (Referenced to GND) | -0.5 to $\mathrm{V}_{\mathrm{CC}}+0.5$ | V | fields. However, precautions must |
| $V_{\text {out }}$ | DC Output Voltage (Referenced to GND) | -0.5 to $\mathrm{V}_{\mathrm{cc}}+0.5$ | V | be taken to avoid applications of any voltage higher than maximum rated |
| $\mathrm{l}_{\text {in }}$ | DC Input Current, per Pin | $\pm 20$ | mA | voltages to this high-impedance cir- |
| Iout | DC Output Current, per Pin | $\pm 25$ | mA | it. For proper operation, $V_{\text {in }}$ and out should be constrained to the |
| ICC | DC Supply Current, $\mathrm{V}_{\mathrm{CC}}$ and GND Pins | $\pm 50$ | mA | range GND $\leq\left(\mathrm{V}_{\text {in }}\right.$ or $\left.\mathrm{V}_{\text {out }}\right) \leq \mathrm{V}_{\text {cc }}$. |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation in Still Air, SOIC Package <br> TSSOP Package <br>   | $500$ | nW | tied to an appropriate logic voltage Nevel (e.g., either GND or $\mathrm{V}_{\mathrm{CC}}$ ). |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature | -65 to + 150 | ${ }^{\circ} \mathrm{C}$ | Unused outputs must be left open. |
| $\mathrm{V}_{\text {ESD }}$ | ESD Withstand Voltage <br> Human Body Model (Note 1) Machine Model (Note 2) | $\begin{array}{r} >2000 \\ >200 \end{array}$ |  |  |
| $\mathrm{I}_{\text {Latchup }}$ | Latchup Performance Above $V_{D D}$ and Below GND at $125^{\circ} \mathrm{C}$ (Note 3) | $\pm 100$ | mA |  |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation abovethe Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Tested to EIA / JESD22-A114-A.
2. Tested to EIA / JESD22-A115-A.
3. Tested to EIA / JESD78.

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC Supply Voltage (Referenced to GND) | 4.5 | 5.5 | V |
| $\mathrm{~V}_{\text {in }}, \mathrm{V}_{\text {out }}$ | DC Input Voltage, Output Voltage (Referenced to GND) | 0 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Temperature, All Package Types | -55 | +125 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{t}_{\mathrm{r}}, \mathrm{t}_{\mathrm{f}}$ | Input Rise and Fall Time (Figure 2) | 0 | 500 | ns |

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

| Symbol | Parameter | Test Conditions | $\stackrel{\mathrm{v}_{\mathrm{cc}}}{\mathbf{V}}$ | Guaranteed Limit |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | $\begin{gathered} -55 \text { to } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | $\leq 85^{\circ} \mathrm{C}$ | $\leq 125^{\circ} \mathrm{C}$ |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Minimum High-Level Input Voltage | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.1 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{CC}}-0.1 \mathrm{~V} \\ & \mid l_{\text {out }} \leq 20 \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 5.5 \end{aligned}$ | $\begin{aligned} & 2.0 \\ & 2.0 \end{aligned}$ | $\begin{aligned} & 2.0 \\ & 2.0 \end{aligned}$ | $\begin{aligned} & \hline 2.0 \\ & 2.0 \end{aligned}$ | V |
| $\mathrm{V}_{\text {IL }}$ | Maximum Low-Level Input Voltage | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.1 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{CC}}-0.1 \mathrm{~V} \\ & \mid l_{\text {out }} \leq 20 \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 5.5 \end{aligned}$ | $\begin{aligned} & 0.8 \\ & 0.8 \end{aligned}$ | $\begin{aligned} & 0.8 \\ & 0.8 \end{aligned}$ | $\begin{aligned} & 0.8 \\ & 0.8 \end{aligned}$ | V |
| $\mathrm{V}_{\mathrm{OH}}$ | Minimum High-Level Output Voltage | $\begin{aligned} & \mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{IH}} \text { or } \mathrm{V}_{\mathrm{IL}} \\ & \mid l_{\text {out }} \leq 20 \leq 20 \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 5.5 \end{aligned}$ | $\begin{aligned} & 4.4 \\ & 5.4 \end{aligned}$ | $\begin{aligned} & 4.4 \\ & 5.4 \end{aligned}$ | $\begin{aligned} & 4.4 \\ & 5.4 \end{aligned}$ | V |
|  |  | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}} \quad\left\|\mathrm{l}_{\text {out }}\right\| \leq 5.2 \mathrm{~mA}$ | 4.5 | 3.98 | 3.84 | 3.70 |  |
| $\mathrm{V}_{\mathrm{OL}}$ | Maximum Low-Level Output Voltage | $\begin{aligned} & \mathrm{V}_{\text {in }} \mathrm{V}_{\mathrm{IH}} \text { or } \mathrm{V}_{\mathrm{IL}} \\ & \mid l_{\text {out }} \leq 20 \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 5.5 \end{aligned}$ | $\begin{aligned} & 0.1 \\ & 0.1 \end{aligned}$ | $\begin{aligned} & \hline 0.1 \\ & 0.1 \end{aligned}$ | $\begin{aligned} & \hline 0.1 \\ & 0.1 \end{aligned}$ | V |
|  |  | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}} \quad\left\|\mathrm{l}_{\text {out }}\right\| \leq 5.2 \mathrm{~mA}$ | 4.5 | 0.26 | 0.33 | 0.40 |  |
| $\mathrm{l}_{\text {in }}$ | Maximum Input Leakage Current | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\text {CC }}$ or GND | 5.5 |  |  | $\pm 1 \cdot 0$ | $\mu \mathrm{A}$ |
| $I_{\text {cc }}$ | Maximum Quiescent Supply Current (per Package) | $\begin{aligned} & \mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{CC}} \text { or GND } \\ & \mathrm{I}_{\text {out }}=0 \mu \mathrm{~A} \end{aligned}$ |  |  |  | - 160 | $\mu \mathrm{A}$ |



AC ELECTRICAL CHARACTERISTICS ( $\mathrm{V}_{\mathrm{CC}}=4.5$ to $5.5 \mathrm{~V}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$, Input $\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=6 \mathrm{~ns}$ )

|  | Parameter | Guaranteed Limit |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Symbol |  | $\begin{gathered} -55 \text { to } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | $\leq 85^{\circ} \mathrm{C}$ | $\leq 125^{\circ} \mathrm{C}$ |  |
| $t_{\text {pLH }}$, <br> $\mathrm{t}_{\mathrm{PHL}}$ | Maximum Propagation Delay, Data to Output (Figures 2 and 7) | 32 | 32 | 42 | ns |
| $\begin{aligned} & \text { tpLH, } \\ & \mathrm{t}_{\mathrm{PH}}, \end{aligned}$ | Maximum Propagation Delay, Address Select to Output (Figures 3 and 7) | 32 | 40 | 45 | ns |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{LLH}}, \\ & \mathrm{t}_{\text {PHL }} \end{aligned}$ | Maximum Propagation Delay, Enable to Output (Figures 4 and 7) | 32 | 40 | 45 | ns |
| $\mathrm{t}_{\text {PHL }}$ | Maximum Propagation Delay, Reset to Output (Figures 5 and 7) | 22 | 26 | 32 | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{TLH}}, \\ & \mathrm{t}_{\mathrm{THL}} \end{aligned}$ | Maximum Output Transition Time, Any Output (Figures 2 and 7) | 15 | 19 | 22 | ns |
| $\mathrm{C}_{\text {in }}$ | Maximum Input Capacitance | 10 10 |  | 10 | pF |
|  |  |  |  |  |  |
| $\mathrm{CPD}^{\text {P }}$ | Power Dissipation Capacitance (Per Package) | $\text { Typical@ } 25^{\circ} \mathrm{C}, \mathrm{~V}_{\mathrm{CC}}=5.0 \mathrm{~V}$ |  |  | pF |

TIMING REQUIREMENTS ( $\mathrm{V}_{\mathrm{CC}}=4.5$ to 5.5 V , Input $\left.\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=6 \mathrm{~ns}\right)$


## SWITCHING WAVEFORMS



Figure 2.

Figure 4.
Figure 3.


Figure 5.


Figure 6.


Figure 7. Test Circuit


Figure 8. Expanded Logic Diagram

ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :--- | :--- | :---: |
| MC74HCT259ADG | SOIC-16 <br> (Pb-Free) | 48 Units / Rail |
| MC74HCT259ADR2G | SOIC-16 <br> (Pb-Free) | 2500 Tape \& Reel |
| MC74HCT259ADTR2G | TSSOP-16* | 2500 Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
*This package is inherently Pb -Free.

SOIC-16 9.90x3.90×1.50 1.27P
CASE 751B
ISSUE L
DATE 29 MAY 2024

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
2. DIMENSION IN MILLIMETERS. ANGLE IN DEGREES.
3. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 mm PER SIDE.
5. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 mm TOTAL IN EXCESS OF THE b DIMENSION AT MAXIMUM MATERIAL CONDITION.


| MILLIMETERS |  |  |  |
| :---: | :---: | :---: | :---: |
| DIM | MIN | NOM | MAX |
| A | 1.35 | 1.55 | 1.75 |
| A1 | 0.00 | 0.05 | 0.10 |
| A2 | 1.35 | 1.50 | 1.65 |
| b | 0.35 | 0.42 | 0.49 |
| c | 0.19 | 0.22 | 0.25 |
| D | 9.90 BSC |  |  |
| E | 6.00 BSC |  |  |
| E1 | 3.90 BSC |  |  |
| e | 1.27 BSC |  |  |
| h | 0.25 | --- | 0.50 |
| L | 0.40 | 0.83 | 1.25 |
| L1 | 1.05 REF |  |  |
| O | 0 | --- | $7 \cdot$ |
| TOLERANCE OF FORM AND POSITION |  |  |  |
| aaa | 0.10 |  |  |
| bbb | 0.20 |  |  |
| ccc | 0.10 |  |  |
| ddd | 0.25 |  |  |
| eee | 0.10 |  |  |



RECOMMENDED MOUNTING FOOTPRINT
*FOR ADDITIONAL INFORMATION ON OUR Pb-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE onsemi SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D

| DOCUMENT NUMBER: | 98ASB42566B |  | Document Repositon: rin red. |
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| DESCRIPTION: | SOIC-16 9.90X3.90X1.50 1.27P |  | PAGE 1 OF 2 |

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## SOIC-16 9.90x3.90x1.50 1.27P CASE 751B ISSUE L

## GENERIC

MARKING DIAGRAM*

*This information is generic. Please refer to device data sheet for actual part marking. $\mathrm{Pb}-\mathrm{Free}$ indicator, " G " or microdot " $\mathrm{=}$ ", may or may not be present. Some products may not follow the Generic Marking.

| STYLE 1: |  | STYLE 2: |  | STYLE 3: |  | STYLE 4: |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PIN 1. | COLLECTOR | PIN 1. | CATHODE | PIN 1. | COLLECTOR, DYE \#1 | PIN 1. | COLLECTOR, DYE \#1 |
| 2. | BASE | 2. | ANODE | 2. | BASE, \#1 | 2. | COLLECTOR, \#1 |
| 3. | Emitter | 3. | NO CONNECTION | 3. | EMITTER, \#1 | 3. | COLLECTOR, \#2 |
| 4. | NO CONNECTION | 4. | CATHODE | 4. | COLLECTOR, \#1 | 4. | COLLECTOR, \#2 |
| 5. | EMITTER | 5. | CATHODE | 5. | COLLECTOR, \#2 | 5. | COLLECTOR, \#3 |
| 6. | BASE | 6. | NO CONNECTION | 6. | BASE, \#2 | 6. | COLLECTOR, \#3 |
| 7. | COLLECTOR | 7. | ANODE | 7. | EMITTER, \#2 | 7. | COLLECTOR, \#4 |
| 8. | COLLECTOR | 8. | CATHODE | 8. | COLLECTOR, \#2 | 8. | COLLECTOR, \#4 |
| 9. | BASE | 9. | CATHODE | 9. | COLLECTOR, \#3 | 9. | BASE, \#4 |
| 10. | EMITTER | 10. | ANODE | 10. | BASE, \#3 | 10. | EMITTER, \#4 |
| 11. | NO CONNECTION | 11. | NO CONNECTION | 11. | EMITTER, \#3 | 11. | BASE, \#3 |
| 12. | EMITTER | 12. | CATHODE | 12. | COLLECTOR, \#3 | 12. | EMITTER, \#3 |
| 13. | BASE | 13. | CATHODE | 13. | COLLECTOR, \#4 | 13. | BASE, \#2 |
| 14. | COLLECTOR | 14. | NO CONNECTION | 14. | BASE, \#4 | 14. | EMITTER, \#2 |
| 15. | EMITTER | 15. | ANODE | 15. | EMITTER, \#4 | 15. | BASE, \#1 |
| 16. | COLLECTOR | 16. | CATHODE | 16. | COLLECTOR, \#4 | 16. | EMITTER, \#1 |
| STYLE 5: |  | STYLE 6: |  | STYLE 7: |  |  |  |
| PIN 1. | DRAIN, DYE \#1 | PIN 1. | CATHODE | PIN 1. | SOURCE N-CH |  |  |
| 2. | DRAIN, \#1 | 2. | CATHODE | 2. | COMMON DRAIN (OUTPUT) |  |  |
| 3. | DRAIN, \#2 | 3. | CATHODE | 3. | COMMON DRAIN (OUTPUT) |  |  |
| 4. | DRAIN, \#2 | 4. | CATHODE | 4. | GATE P-CH |  |  |
| 5. | DRAIN, \#3 | 5. | CATHODE | 5. | COMMON DRAIN (OUTPUT) |  |  |
| 6. | DRAIN, \#3 | 6. | CATHODE | 6. | COMMON DRAIN (OUTPUT) |  |  |
| 7. | DRAIN, \#4 | 7. | CATHODE | 7. | COMMON DRAIN (OUTPUT) |  |  |
| 8. | DRAIN, \#4 | 8. | CATHODE | 8. | SOURCE P-CH |  |  |
| 9. | GATE, \#4 | 9. | ANODE | 9. | SOURCE P-CH |  |  |
| 10. | SOURCE, \#4 | 10. | ANODE | 10. | COMMON DRAIN (OUTPUT) |  |  |
| 11. | GATE, \#3 | 11. | ANODE | 11. | COMMON DRAIN (OUTPUT) |  |  |
| 12. | SOURCE, \#3 | 12. | ANODE | 12. | COMMON DRAIN (OUTPUT) |  |  |
| 13. | GATE, \#2 | 13. | ANODE | 13. | GATE N-CH |  |  |
| 14. | SOURCE, \#2 | 14. | ANODE | 14. | COMMON DRAIN (OUTPUT) |  |  |
| 15. | GATE, \#1 | 15. | ANODE | 15. | COMMON DRAIN (OUTPUT) |  |  |
| 16. | SOURCE, \#1 | 16. | ANODE | 16. | SOURCE N-CH |  |  |


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| DESCRIPTION: | SOIC-16 9.90X3.90X1.501.27P | PAGE 2 OF 2 |

[^1]

TSSOP-16 WB
CASE 948F
ISSUE B
DATE 19 OCT 2006


1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 ( 0.006 ) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 ( 0.010 ) PER SIDE.
5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL in EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE - $W$ -

| DIM | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |
| A | 4.90 | 5.10 | 0.193 | 0.200 |
| B | 4.30 | 4.50 | 0.169 | 0.177 |
| c |  | 1.20 |  | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 | SC | 0.026 | BSC |
| H | 0.18 | 0.28 | 0.007 | 0.011 |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 | BC | 0.25 | BSC |
| M | $0^{\circ}$ | $8^{\circ}$ | $0^{\circ}$ | $8^{\circ}$ |



| GENERIC <br> MARKING DIAGRAM* |  |
| :---: | :---: |
|  |  |
| XXXX | = Specific Device Code |
| A | = Assembly Location |
| L | = Wafer Lot |
| Y | = Year |
| W | = Work Week |
| G or - | = Pb-Free Package |

*This information is generic. Please refer to device data sheet for actual part marking. $\mathrm{Pb}-$ Free indicator, " G " or microdot " $\mathrm{\bullet}$ ", may or may not be present. Some products may not follow the Generic Marking.
*For additional information on our $\mathrm{Pb}-$ Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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